## Notice of References Cited Application/Control No. 10/002,745 Examiner Philip J. Chea Applicant(s)/Patent Under Reexamination UENO, TOSHIO Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,766,320	07-2004	Wang et al.	707/5
	В	US-5,197,005 A	03-1993	Shwartz et al.	707/2
	С	US-5,446,883 A	08-1995	Kirkbride et al.	707/10
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-		·	
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	Z					
	0					
	Р					
	Q					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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